INTERNATIONAL SEARCH REPORT

national Application No

A. CLASSIFICATION OF SUBJECT MATTER IPC 7 G01N23/227 H01J49/08 H01J37/05								
According to International Patent Classification (IPC) or to both national classification and IPC								
B. FIELDS SEARCHED								
Minimum documentation searched (classification system followed by classification symbols) IPC 7 G01N H01J								
	ion searched other than minimum documentation to the extent that su							
Electronic data base consulted during the International search (name of data base and, where practical, search terms used) EPO-Internal, PAJ, INSPEC								
C. DOCUMI	ENTS CONSIDERED TO BE RELEVANT							
Category °	Citation of document, with indication, where appropriate, of the rele	vant passages	Relevant to claim No.					
Υ	HAYASHI T ET AL: "ENERGY LOSS NE STRUCTURE FOR MATERIALS CONTAININ ELEMENTS BY REFLECTION ELECTRON E LOSS SPECTROSCOPY"	1,2						
	APPLIED PHYSICS LETTERS, AMERICAN INSTITUTE OF PHYSICS. NEW YORK, L vol. 66, no. 1, 2 January 1995 (1995-01-02), page XP000485955 ISSN: 0003-6951 figure 1	·						
A	US 6 104 029 A (VON HARRACH H SEI ET AL) 15 August 2000 (2000-08-1! figure 1	1,2						
	listed in the continuation of box C	X Patent family members are listed	in annex.					
	rther documents are listed in the continuation of box C.							
 Special categories of cited documents: A* document defining the general state of the art which is not considered to be of particular relevance T* later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention 								
filing "L" docur which	er document but published on or after the International g date ment which may throw doubts on priority claim(s) or ch is cited to establish the publication date of another	X' document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone Y' document of particular relevance; the claimed invention						
O' docu	tion or other special reason (as specified) Iment referring to an oral disclosure, use, exhibition or Iment referring to an oral disclosure, use, exhibition or Iment published prior to the international filing date but	cannot be considered to involve an i document is combined with one or n ments, such combination being obvi in the art.	nore other such docu- ous to a person skilled					
late	r than the priority date claimed	& document member of the same patent family						
Date of th	ne actual completion of the International search	Date of mailing of the international se	salon repor					
	7 December 2004							
Name and mailing address of the ISA European Patent Office, P.B. 5818 Patentlaan 2 NL – 2280 HV Rijswijk		Authorized officer						
1	Tel. (+31-70) 340-2040, Tx. 31 651 epo nl, Fax: (+31-70) 340-3016	Strohmayer, B						

INTERNATIONAL SEARCH REPORT

I ational Application No rc I/IT2004/000555

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT						
Category °	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.				
A	G. ERTL, J. KÜPPERS: "Low Energy Electrons and Surface Chemistry" 1985, VCH VERLAGSGESELLSCHAFT MBH, WEINHEIM, GERMANY, PAGES 6-25,185-201,285-291, XP002309246 ISBN: 3-527-26056-0 page 14 page 286 - page 288; figures 11.1,11.2	1,2				
Y	MOOK H W ET AL: "Electrostatic in-line monochromator for Schottky field emission gun" INSTITUTE OF PHYSICS CONFERENCE SERIES, IOP PUBLISHING, GB, no. 153, 1997, pages 81-84, XP002110008 ISSN: 0951-3248 abstract paragraph "1. Introduction"	1,2				
Α	US 2001/052744 A1 (TSUNO KATSUSHIGE) 20 December 2001 (2001-12-20) abstract paragraph '0004! - paragraph '0005! paragraph '0056! - paragraph '0057!	1,2				
A	BROWNING R ET AL: "A DIGITAL SCANNING AUGER ELECTRON MICROSCOPE INCORPORATING A CONCENTRIC HEMISPHERICAL ANALYSER" PROCEEDINGS OF THE ROYAL SOCIETY OF LONDON. SERIES A, MATHEMATICAL AND PHYSICAL SCIENCES, ROYAL SOCIETY OF LONDON, LONDON, GB, vol. 357, no. 1689, 1977, pages 213-230, XP000989498 ISSN: 0080-4630 abstract paragraph "3. THE INSTRUMENT"	1,2				
A	HENRARD L ET AL: "Electron-energy-loss spectroscopy of plasmon excitations in concentric-shell fullerenes" PHYSICAL REVIEW B (CONDENSED MATTER) APS THROUGH AIP USA, vol. 59, no. 8, 15 February 1999 (1999-02-15), pages 5832-5836, XP002309245 ISSN: 0163-1829 page 5833, left-hand column, paragraph 2; figure 2	1,2				

INTERNATIONAL SEARCH REPORT

Information on patent family members

onal Application No

Patent document cited in search report		Publication date		Patent family member(s)	Publication date
US 6104029	Α	15-08-2000	GB	2328792 A ,B	03-03-1999
US 2001052744	A1	20-12-2001	JP	2001357809 A	26-12-2001